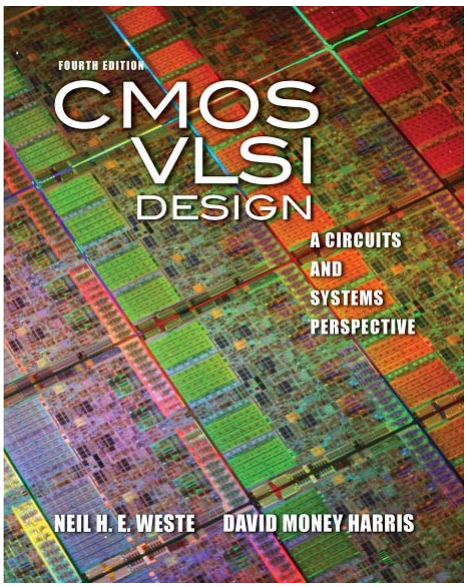


Lecture 0: Introduction

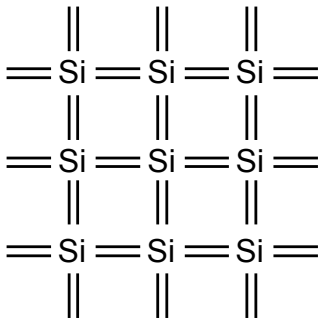
Prof. Ioannis Savidis

Introduction

- Integrated circuits: many transistors on one chip.
- *Very Large Scale Integration* (VLSI): bucketloads!
- *Complementary Metal Oxide Semiconductor*
  - Fast, cheap, low power transistors
- Today: How to build your own simple CMOS chip
  - CMOS transistors
  - Building logic gates from transistors
  - Transistor layout and fabrication
- Rest of the course: How to build a good CMOS chip

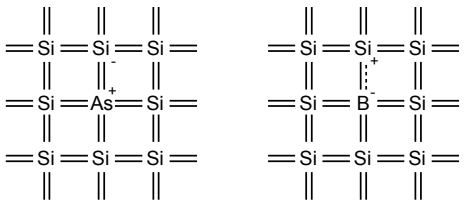
Silicon Lattice

- Transistors are built on a silicon substrate
- Silicon is a Group IV material
- Forms crystal lattice with bonds to four neighbors



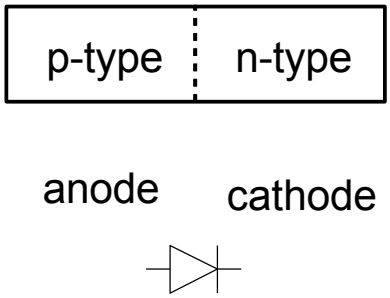
Dopants

- Silicon is a semiconductor
- Pure silicon has no free carriers and conducts poorly
- Adding dopants increases the conductivity
- Group V: extra electron (n-type)
- Group III: missing electron, called hole (p-type)



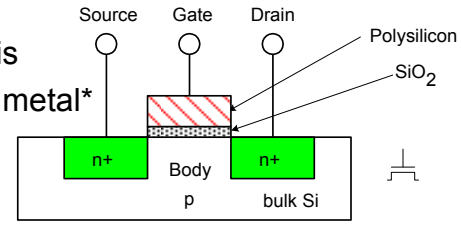
p-n Junctions

- A junction between p-type and n-type semiconductor forms a diode.
- Current flows only in one direction



nMOS Transistor

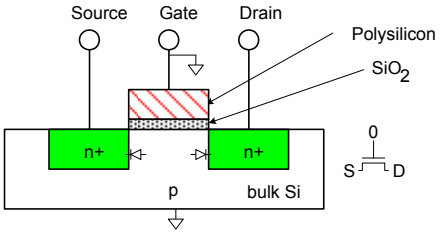
- Four terminals: gate, source, drain, body
- Gate – oxide – body stack looks like a capacitor
  - Gate and body are conductors
  - SiO_2 (oxide) is a very good insulator
  - Called metal – oxide – semiconductor (MOS) capacitor
  - Even though gate is no longer made of metal*



* Metal gates are returning today!

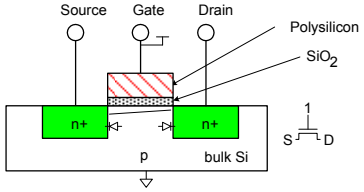
nMOS Operation

- Body is usually tied to ground (0 V)
- When the gate is at a low voltage:
  - P-type body is at low voltage
  - Source-body and drain-body diodes are OFF
  - No current flows, transistor is OFF



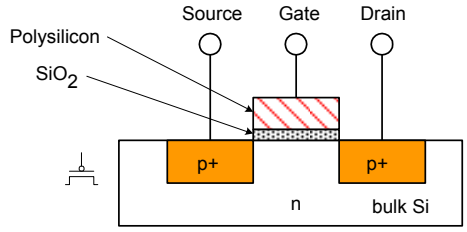
nMOS Operation Cont.

- When the gate is at a high voltage:
  - Positive charge on gate of MOS capacitor
  - Negative charge attracted to body
  - Inverts a channel under gate to n-type
  - Now current can flow through n-type silicon from source through channel to drain, transistor is ON



pMOS Transistor

- Similar, but doping and voltages reversed
  - Body tied to high voltage (V_{DD})
  - Gate low: transistor ON
  - Gate high: transistor OFF
  - Bubble indicates inverted behavior

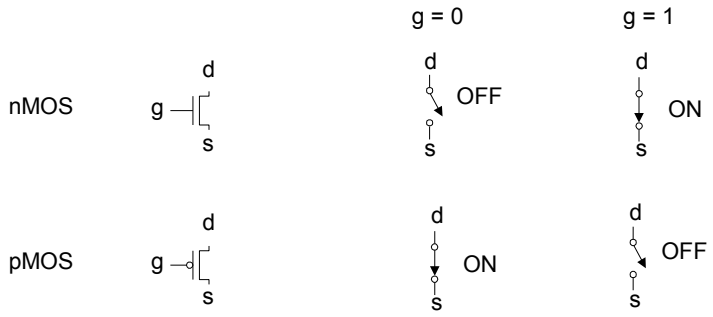


Power Supply Voltage

- GND = 0 V
- In 1980's, V_{DD} = 5V
- V_{DD} has decreased in modern processes
  - High V_{DD} would damage modern tiny transistors
  - Lower V_{DD} saves power
- V_{DD} = 3.3, 2.5, 1.8, 1.5, 1.2, 1.0, …

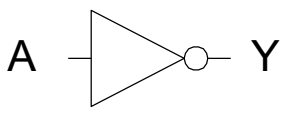
Transistors as Switches

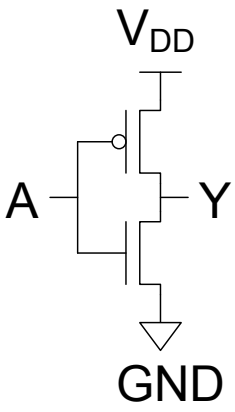
- We can view MOS transistors as electrically controlled switches
- Voltage at gate controls path from source to drain



CMOS Inverter

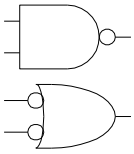
A	Y

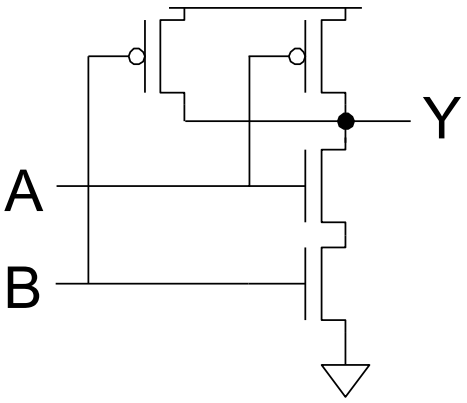




CMOS NAND Gate

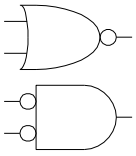
A	B	Y
0	0	
0	1	
1	0	
1	1	

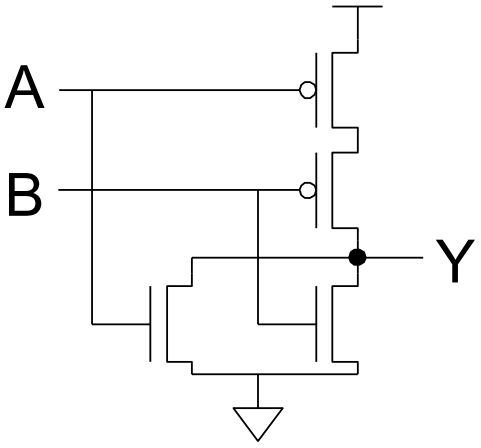




CMOS NOR Gate

A	B	Y
0	0	1
0	1	0
1	0	0
1	1	0





3-input NAND Gate

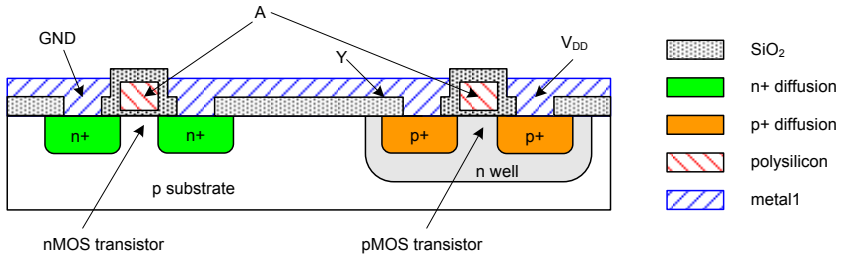
- Y pulls low if ALL inputs are 1
- Y pulls high if ANY input is 0

CMOS Fabrication

- CMOS transistors are fabricated on silicon wafer
- Lithography process similar to printing press
- On each step, different materials are deposited or etched
- Easiest to understand by viewing both top and cross-section of wafer in a simplified manufacturing process

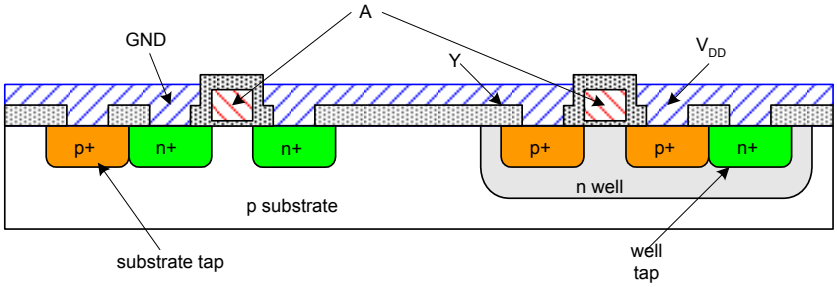
Inverter Cross-section

- Typically use p-type substrate for nMOS transistors
- Requires n-well for body of pMOS transistors



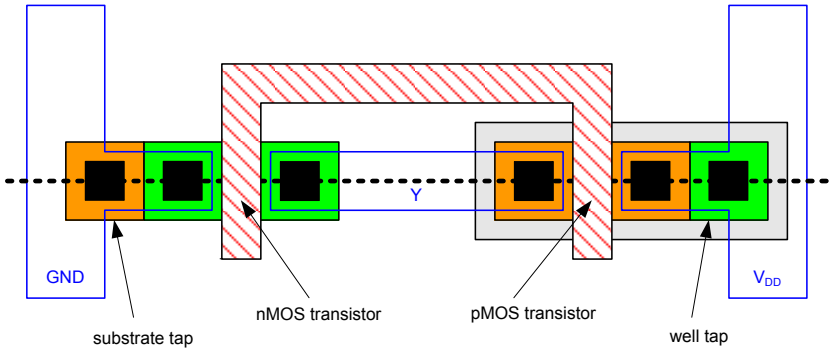
Well and Substrate Taps

- Substrate must be tied to GND and n-well to V_{DD}
- Metal to lightly-doped semiconductor forms poor connection called Shottky Diode
- Use heavily doped well and substrate contacts / taps



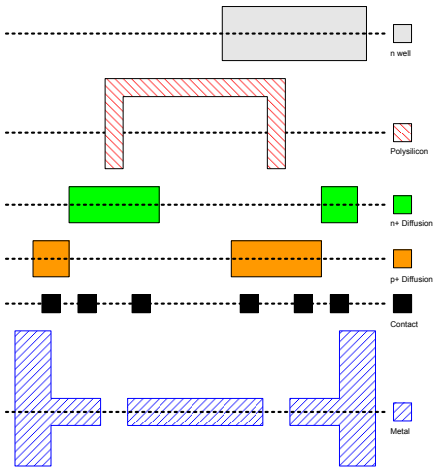
Inverter Mask Set

- Transistors and wires are defined by *masks*
- Cross-section taken along dashed line



Detailed Mask Views

- Six masks
  - n-well
  - Polysilicon
  - n+ diffusion
  - p+ diffusion
  - Contact
  - Metal



Fabrication

- Chips are built in huge factories called fabs
- Contain clean rooms as large as football fields

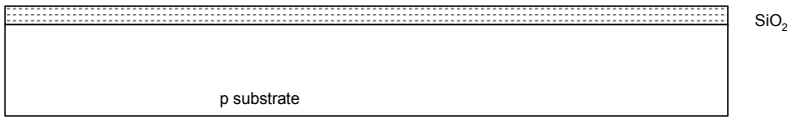
Courtesy of International Business Machines Corporation. Unauthorized use not permitted.

Fabrication Steps

- Start with blank wafer
- Build inverter from the bottom up
- First step will be to form the n-well
  - Cover wafer with protective layer of SiO_2 (oxide)
  - Remove layer where n-well should be built
  - Implant or diffuse n dopants into exposed wafer
  - Strip off SiO_2

Oxidation

- Grow SiO_2 on top of Si wafer
  - 900 – 1200 C with H_2O or O_2 in oxidation furnace

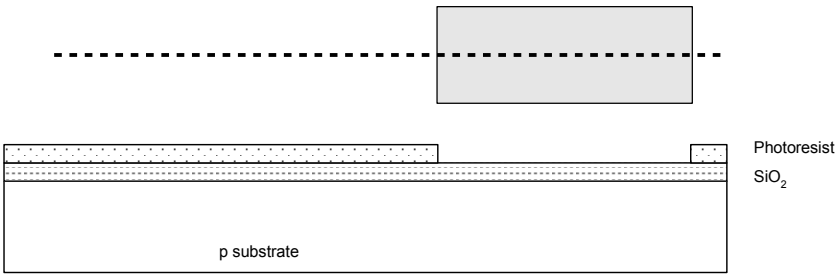


Photoresist

- Spin on photoresist
  - Photoresist is a light-sensitive organic polymer
  - Softens where exposed to light

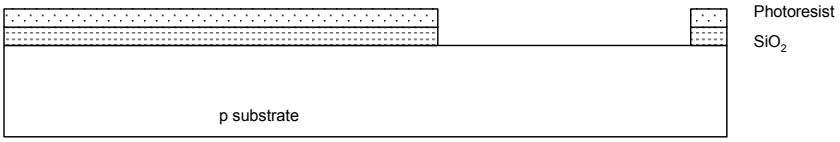
Lithography

- Expose photoresist through n-well mask
- Strip off exposed photoresist



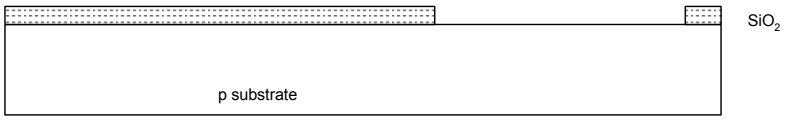
Etch

- Etch oxide with hydrofluoric acid (HF)
  - Seeps through skin and eats bone; nasty stuff!!!
- Only attacks oxide where resist has been exposed



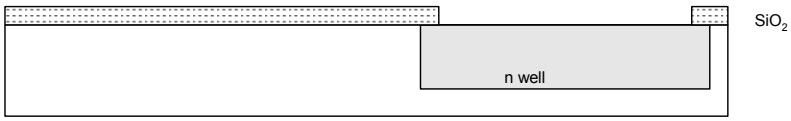
Strip Photoresist

- Strip off remaining photoresist
  - Use mixture of acids called piranah etch
- Necessary so resist doesn't melt in next step



n-well

- n-well is formed with diffusion or ion implantation
- Diffusion
  - Place wafer in furnace with arsenic gas
  - Heat until As atoms diffuse into exposed Si
- Ion Implanatation
  - Blast wafer with beam of As ions
  - Ions blocked by SiO_2, only enter exposed Si

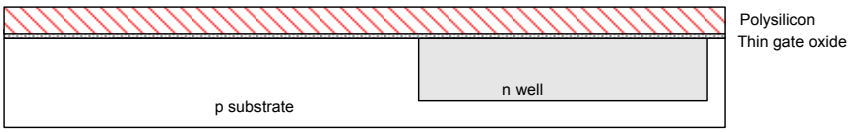


Strip Oxide

- Strip off the remaining oxide using HF
- Back to bare wafer with n-well
- Subsequent steps involve similar series of steps

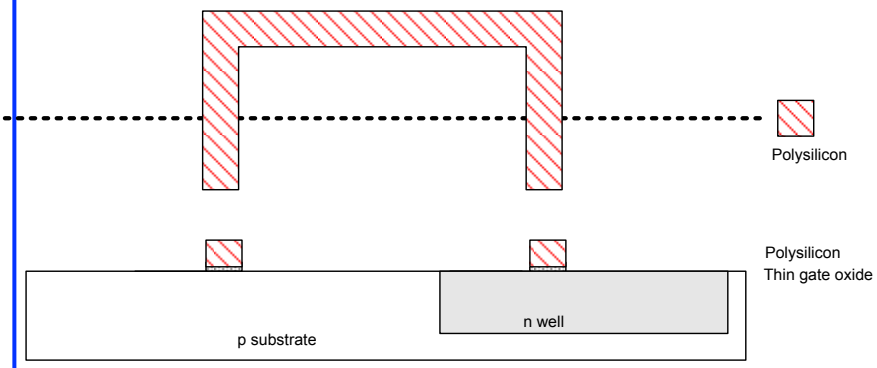
Polysilicon

- Deposit very thin layer of gate oxide
  - < 20 Å (6-7 atomic layers)
- Chemical Vapor Deposition (CVD) of silicon layer
  - Place wafer in furnace with Silane gas (SiH_4)
  - Forms many small crystals called polysilicon
  - Heavily doped to be good conductor



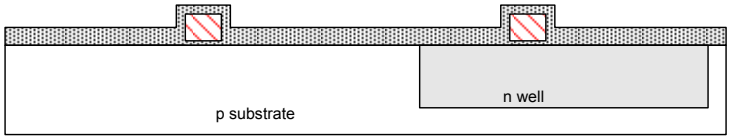
Polysilicon Patterning

- Use same lithography process to pattern polysilicon



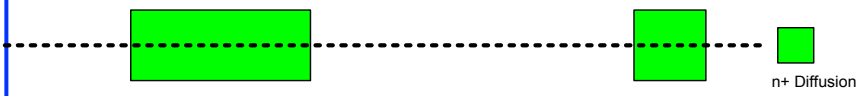
Self-Aligned Process

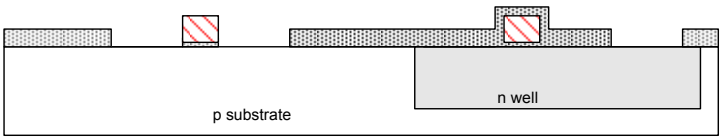
- Use oxide and masking to expose where n+ dopants should be diffused or implanted
- N-diffusion forms nMOS source, drain, and n-well contact



N-diffusion

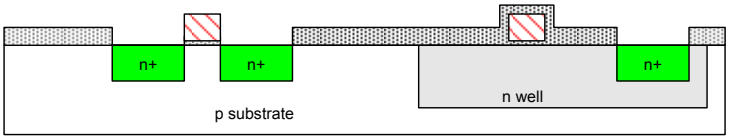
- Pattern oxide and form n+ regions
- *Self-aligned process* where gate blocks diffusion
- Polysilicon is better than metal for self-aligned gates because it doesn't melt during later processing





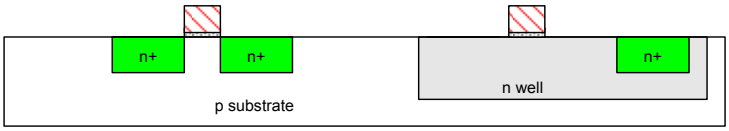
N-diffusion cont.

- Historically dopants were diffused
- Usually ion implantation today
- But regions are still called diffusion



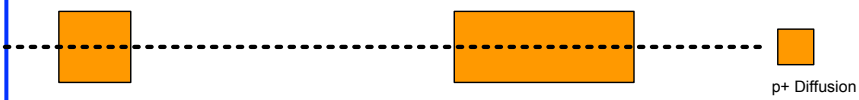
N-diffusion cont.

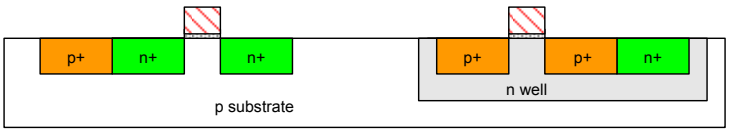
- Strip off oxide to complete patterning step



P-Diffusion

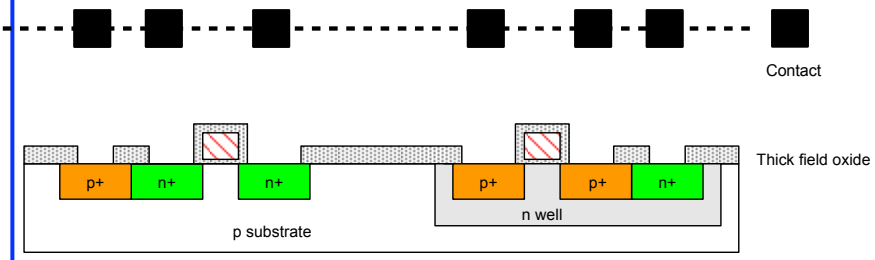
- Similar set of steps form p+ diffusion regions for pMOS source and drain and substrate contact





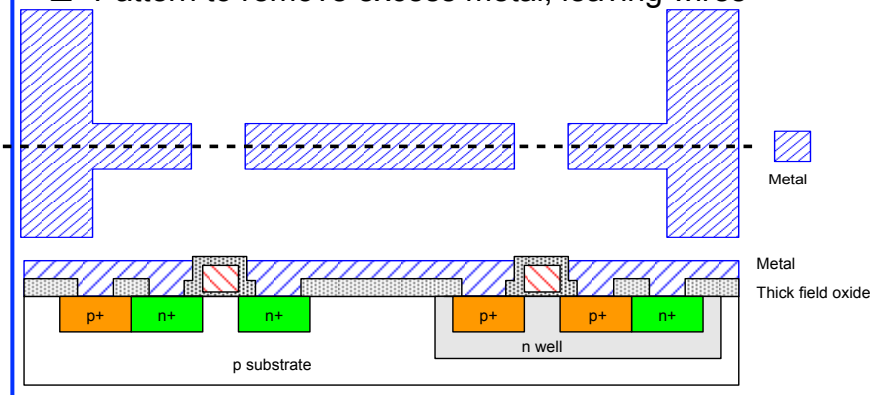
Contacts

- Now we need to wire together the devices
- Cover chip with thick field oxide
- Etch oxide where contact cuts are needed



Metalization

- Sputter on aluminum over whole wafer
- Pattern to remove excess metal, leaving wires

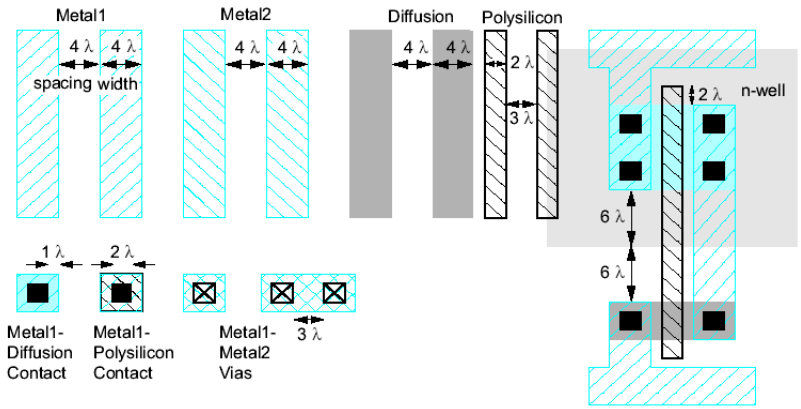


Layout

- Chips are specified with set of masks
- Minimum dimensions of masks determine transistor size (and hence speed, cost, and power)
- Feature size *f* = distance between source and drain
  - Set by minimum width of polysilicon
- Feature size improves 30% every 3 years or so
- Normalize for feature size when describing design rules
- Express rules in terms of λ = *f*/2
  - E.g. λ = 0.3 μm in 0.6 μm process

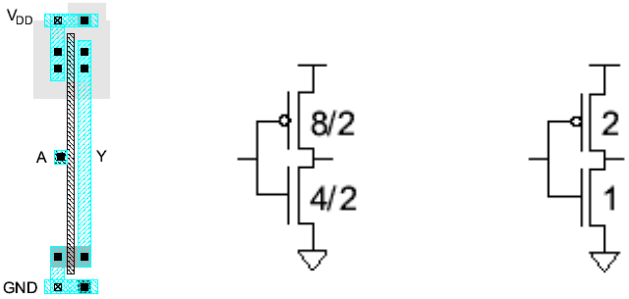
Simplified Design Rules

- Conservative rules to get you started



Inverter Layout

- Transistor dimensions specified as Width / Length
  - Minimum size is 4λ / 2λ, sometimes called 1 unit
  - In *f* = 0.6 μm process, this is 1.2 μm wide, 0.6 μm long



Summary

- MOS transistors are stacks of gate, oxide, silicon
- Act as electrically controlled switches
- Build logic gates out of switches
- Draw masks to specify layout of transistors

- Now you know everything necessary to start designing schematics and layout for a simple chip!

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